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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/783,466	02/20/2004	Yakov Roizin	TSL-135	7443	
22888 7590 02/26/2007 BEVER HOFFMAN & HARMS, LLP TRI-VALLEY OFFICE			EXAMINER		
			SCHILLINGER, LAURA M		
1432 CONCANNON BLVD., BLDG. G LIVERMORE, CA 94550			ART UNIT	PAPER NUMBER	
			2813		
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SHORTENED STATUTO	RY PERIOD OF RESPONSE	MAIL DATE	DELIVER	DELIVERY MODE	
3 MC	ONTHE	02/26/2007	DADED		

Please find below and/or attached an Office communication concerning this application or proceeding.

If NO period for reply is specified above, the maximum statutory period will apply and will expire 6 MONTHS from the mailing date of this communication.

		Application No.	Applicant(s)				
Office Action Summary		10/783,466	ROIZIN ET AL.				
		Examiner	Art Unit				
		Laura M. Schillinger	2813				
Period fo	The MAILING DATE of this communication app or Reply	ears on the cover sheet with the c	orrespondence address				
WHIC - Exter after - If NO - Failu Any	ORTENED STATUTORY PERIOD FOR REPLY CHEVER IS LONGER, FROM THE MAILING DATE in a sions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. In period for reply is specified above, the maximum statutory period were to reply within the set or extended period for reply will, by statute, eply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim rill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONEI	I. lely filed the mailing date of this communication. D (35 U.S.C. § 133).				
Status							
1)⊠	Responsive to communication(s) filed on <u>01 Fe</u>	ebruary 2007.					
	This action is FINAL . 2b)⊠ This action is non-final.						
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.							
Dispositi	on of Claims						
4)⊠	4)⊠ Claim(s) <u>1-15</u> is/are pending in the application.						
	4a) Of the above claim(s) is/are withdrawn from consideration.						
5)	5) Claim(s) is/are allowed.						
6)⊠	☑ Claim(s) <u>1-6 and 8-15</u> is/are rejected.						
	Claim(s) <u>7</u> is/are objected to.						
8)[Claim(s) are subject to restriction and/or	election requirement.					
Applicati	on Papers		•				
9)	The specification is objected to by the Examine	r.					
10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.							
	Applicant may not request that any objection to the						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).							
11)	The oath or declaration is objected to by the Ex	aminer. Note the attached Office	Action or form PTO-152.				
Priority u	ınder 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of:							
1. Certified copies of the priority documents have been received.							
	2. Certified copies of the priority documents have been received in Application No						
3. Copies of the certified copies of the priority documents have been received in this National Stage							
	application from the International Bureau (PCT Rule 17.2(a)).						
* See the attached detailed Office action for a list of the certified copies not received.							
Attachmen	t(s)						
	e of References Cited (PTO-892)	4) Interview Summary					
	e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO/SB/08)	Paper No(s)/Mail Da 5) Notice of Informal P					
Paper No(s)/Mail Date 6) Other:							

DETAILED ACTION

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 8 recites the limitation "depositing a top dielectric layer over the **nitride** layer. Claim 8 depends on claim 1, claim 1 does not recite a nitride layer. There is insufficient antecedent basis for this limitation in the claim. Consequently, claim 8 is rejected under 112, 2nd paragraph. Moreover, claims 9-11 depend from claim 8 and are therefore also rejected on this basis. Claim 15 depends on claim 1 and recites removing the "top dielectric"- claim 1 does not teach forming a top dielectric; claim 3 recites a top dielectric, therefore there is no antecedent basis for this claim language.

Allowable Subject Matter

Claim 7 is objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The following is a statement of reasons for the indication of allowable subject matter: Claim 7 recites further comprising implanting CMOS well regions through the intermediate dielectric layer and the bottom oxide layer in a first region of the semiconductor substrate. Prior art of record fails to teach nor suggest implanting CMOS regions as claimed.

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Claim Rejections - 35 USC § 102

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The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that

form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1-12 and 15 are rejected under 35 U.S.C. 102(e) as being anticipated by Ohtani et al (US 20030157758).

Ohtani teaches the following claimed limitations as cited below:

1. A method for making an embedded semiconductor memory device comprising: forming one or more diffusion bit line regions in a semiconductor substrate (Fig.9B (216/214/212))

then thermally oxidizing the upper surface of the semiconductor substrate, thereby forming a bottom oxide layer over the upper surface of the semiconductor substrate and simultaneously forming bit line oxide regions over each of the one or more diffusion bit line regions (Fig.10A (1000 abc) and

then forming an intermediate dielectric layer over the bottom oxide layer and the bit line oxide regions (Fig.11A (1102/800a-b/802a-b/700Aa-Ab/).

- 2. The method of Claim 1, wherein the intermediate dielectric layer comprises silicon nitride ((700Aa/700Ab/1102).
- 3. The method of Claim 1, further comprising depositing a top dielectric layer over the intermediate dielectric layer using a chemical vapor deposition process (800a/802b/1102-Col.9, lines: 10-20- the top oxide layer of the ONO layer).
- 4. The method of Claim 3, wherein the top dielectric layer is formed by depositing high-temperature silicon oxide (Fig. 11A (1102/800a/802b) -teaching to form silicon oxide by CVD or thermal oxidation Col.3, lines: 35-45).
- 5. The method of Claim 3, wherein the top dielectric layer is a high dielectric material, having a dielectric constant equal to 4 or greater (Silicon oxide).
- 6. The method of Claim 3, wherein the top dielectric layer is deposited at a temperature of about 750 to 850 degrees C (Col.3, lines: 35-45- thermal oxidation is carried out at such a temperature range).
- 12. The method of Claim 1, further comprising forming shallow trench isolation regions in the semiconductor substrate prior forming the one or more diffusion bit line regions in the semiconductor substrate (Fig.4 (406a and b)).

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Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 13-14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Lu et al ('808).

In reference to claims 13 and 14, Lu teaches the method of Claim 1; however fails to teach wherein each of the bit line oxide regions has a thickness that is about 1.5 to 3 times larger than a thickness of the bottom oxide layer (claim 13) and further fails to teach wherein each bit line oxide region has a thickness in the range of about 50 to Angstroms (claim 14).

These claims are prima facie obvious without showing that the claimed ranges achieve unexpected results relative to the prior art range. In re Woodruff, 16 USPQ2d 1935, 1937 (Fed. Cir. 1990). See also In re Huang, 40 USPQ2d 1685, 1688(Fed. Cir. 1996)(claimed ranges of a result effective variable, which do not overlap the prior art ranges, are unpatentable unless they produce a new and unexpected result which is different in kind and not merely in degree from the results of the prior art). See also In re Boesch, 205 USPQ 215 (CCPA) (discovery of optimum value of result effective variable in known

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process is ordinarily within skill of art) and In re Aller, 105 USPQ 233 (CCPA 1955) (selection of optimum ranges within prior art general conditions is obvious).

Response to Arguments

Applicant's arguments with respect to the above claims have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Laura M. Schillinger whose telephone number is (571) 272-1697. The examiner can normally be reached on M-T, R-F 7:00-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl W. Whitehead, Jr. can be reached on (571) 272-1702. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

02/11/07

Laura M Schillinger Primary Examiner Art Unit 2813